

查询"FDMS7700S"供应商

FAIRCHILD
 SEMICONDUCTOR®

December 2009

FDMS7700S

Dual N-Channel PowerTrench® MOSFET

N-Channel: 30 V, 30 A, 7.5 mΩ N-Channel: 30 V, 40 A, 2.4 mΩ

Features

Q1: N-Channel

- Max $r_{DS(on)}$ = 7.5 mΩ at $V_{GS} = 10$ V, $I_D = 12$ A
- Max $r_{DS(on)}$ = 12 mΩ at $V_{GS} = 4.5$ V, $I_D = 10$ A

Q2: N-Channel

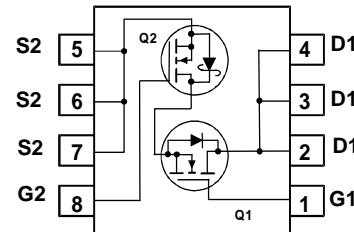
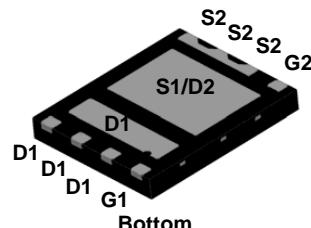
- Max $r_{DS(on)}$ = 2.4 mΩ at $V_{GS} = 10$ V, $I_D = 20$ A
- Max $r_{DS(on)}$ = 2.9 mΩ at $V_{GS} = 4.5$ V, $I_D = 18$ A
- RoHS Compliant

General Description

This device includes two specialized N-Channel MOSFETs in a dual MLP package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous SyncFET (Q2) have been designed to provide optimal power efficiency.

Applications

- Computing
- Communications
- General Purpose Point of Load
- Notebook VCORE



MOSFET Maximum Ratings $T_A = 25$ °C unless otherwise noted

Symbol	Parameter	Q1	Q2	Units
V_{DS}	Drain to Source Voltage	30	30	V
V_{GS}	Gate to Source Voltage	(Note 3)	± 20	V
I_D	Drain Current -Continuous (Package limited)	$T_C = 25$ °C	30	A
	-Continuous (Silicon limited)	$T_C = 25$ °C	50	
	-Continuous	$T_A = 25$ °C	12 ^{1a}	
	-Pulsed		40	
P_D	Power Dissipation for Single Operation	$T_A = 25$ °C	2.2 ^{1a}	W
		$T_A = 25$ °C	1.0 ^{1c}	
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150		°C

Thermal Characteristics

R_{QJA}	Thermal Resistance, Junction to Ambient	57 ^{1a}	50 ^{1b}	°C/W
R_{QJA}	Thermal Resistance, Junction to Ambient	125 ^{1c}	120 ^{1d}	
R_{QJC}	Thermal Resistance, Junction to Case	3.5	2	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS7700S	FDMS7700S	Power 56	13 "	12 mm	3000 units

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Electrical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Type	Min	Typ	Max	Units
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Off Characteristics

BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu\text{A}, V_{GS} = 0 \text{ V}$ $I_D = 1 \text{ mA}, V_{GS} = 0 \text{ V}$	Q1 Q2	30 30			V
$\frac{\Delta \text{BV}_{\text{DSS}}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}, \text{referenced to } 25^\circ\text{C}$ $I_D = 1 \text{ mA}, \text{referenced to } 25^\circ\text{C}$	Q1 Q2		15 14		$\text{mV/}^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$	Q1 Q2			1 500	μA μA
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	Q1 Q2			100 100	nA nA

On Characteristics

$V_{GS(\text{th})}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu\text{A}$ $V_{GS} = V_{DS}, I_D = 1 \text{ mA}$	Q1 Q2	1 1	1.8 1.5	3 3	V
$\frac{\Delta V_{GS(\text{th})}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}, \text{referenced to } 25^\circ\text{C}$ $I_D = 1 \text{ mA}, \text{referenced to } 25^\circ\text{C}$	Q1 Q2		-6 -4		$\text{mV/}^\circ\text{C}$
$r_{DS(\text{on})}$	Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, I_D = 12 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 12 \text{ A}, T_J = 125^\circ\text{C}$	Q1		6.0 8.5 8.3	7.5 12 12	$\text{m}\Omega$
		$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 18 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 125^\circ\text{C}$	Q2		1.9 2.2 2.1	2.4 2.9 3.4	
g_{FS}	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_D = 12 \text{ A}$ $V_{DS} = 5 \text{ V}, I_D = 20 \text{ A}$	Q1 Q2		63 160		s

Dynamic Characteristics

C_{iss}	Input Capacitance	Q1: $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHZ}$	Q1 Q2		1315 7240	1750 9630	pF
C_{oss}	Output Capacitance	Q2: $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHZ}$	Q1 Q2		445 2690	600 3580	pF
C_{rss}	Reverse Transfer Capacitance		Q1 Q2		45 185	70 280	pF
R_g	Gate Resistance		Q1 Q2		0.9 0.8		Ω

Switching Characteristics

$t_{d(\text{on})}$	Turn-On Delay Time	Q1: $V_{DD} = 15 \text{ V}, I_D = 12 \text{ A}, R_{\text{GEN}} = 6 \Omega$	Q1 Q2		8.6 21	18 34	ns
t_r	Rise Time		Q1 Q2		2.5 9.2	10 18	ns
$t_{d(\text{off})}$	Turn-Off Delay Time	Q2: $V_{DD} = 15 \text{ V}, I_D = 20 \text{ A}, R_{\text{GEN}} = 6 \Omega$	Q1 Q2		20 58	32 93	ns
t_f	Fall Time		Q1 Q2		2.3 6.8	10 14	ns
Q_g	Total Gate Charge	$V_{GS} = 0 \text{ V to } 10 \text{ V}$	Q1 Q2		20 105	28 147	nC
Q_g	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V}$	Q1 Q2		9.3 48	13 67	nC
Q_{gs}	Gate to Source Gate Charge	Q2 $V_{DD} = 15 \text{ V}, I_D = 20 \text{ A}$	Q1 Q2		4.3 19		nC
Q_{gd}	Gate to Drain "Miller" Charge		Q1 Q2		2.2 11		nC

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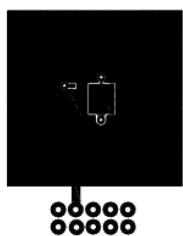
Symbol	Parameter	Test Conditions	Type	Min	Typ	Max	Units
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Drain-Source Diode Characteristics

V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}$, $I_S = 12 \text{ A}$ $V_{GS} = 0 \text{ V}$, $I_S = 20 \text{ A}$	(Note 2) (Note 2)	Q1 Q2		0.8 0.7	1.2 1.2	V
t_{rr}	Reverse Recovery Time	Q1	$I_F = 12 \text{ A}$, $dI/dt = 100 \text{ A}/\mu\text{s}$	Q1		27	43	ns
		Q2		Q2		53	85	
Q_{rr}	Reverse Recovery Charge	Q2	$I_F = 20 \text{ A}$, $dI/dt = 300 \text{ A}/\mu\text{s}$	Q1		10	18	nC
		Q2		Q2		100	160	

Notes:

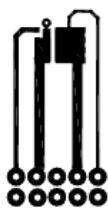
1: R_{QJA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{QJC} is guaranteed by design while R_{QCA} is determined by the user's board design.



a. 57 °C/W when mounted on a 1 in² pad of 2 oz copper



b. 50 °C/W when mounted on a 1 in² pad of 2 oz copper



c. 125 °C/W when mounted on a minimum pad of 2 oz copper



d. 120 °C/W when mounted on a minimum pad of 2 oz copper

2: Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0%.

3: As an N-ch device, the negative V_{GS} rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

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Typical Characteristics (Q1 N-Channel) $T_J = 25^\circ\text{C}$ unless otherwise noted

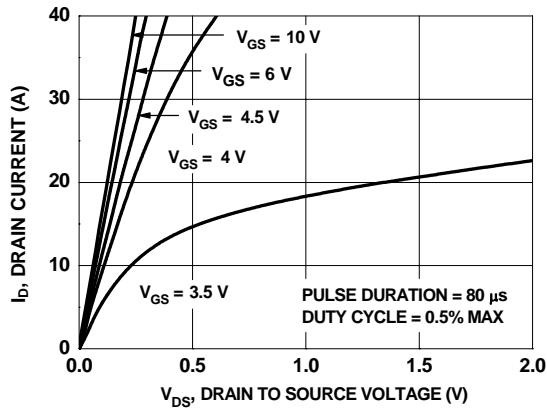


Figure 1. On Region Characteristics

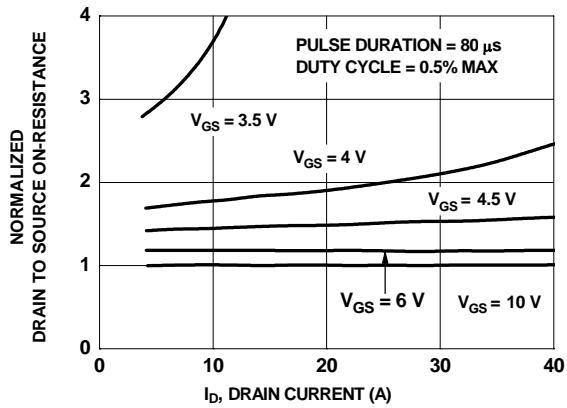


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

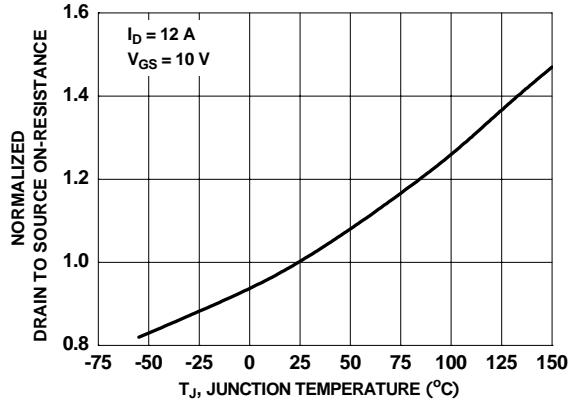


Figure 3. Normalized On Resistance vs Junction Temperature

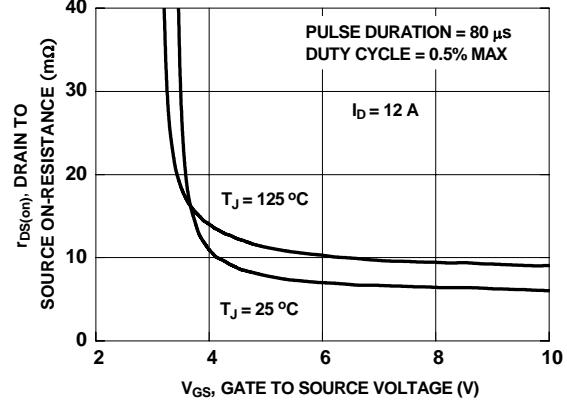


Figure 4. On-Resistance vs Gate to Source Voltage

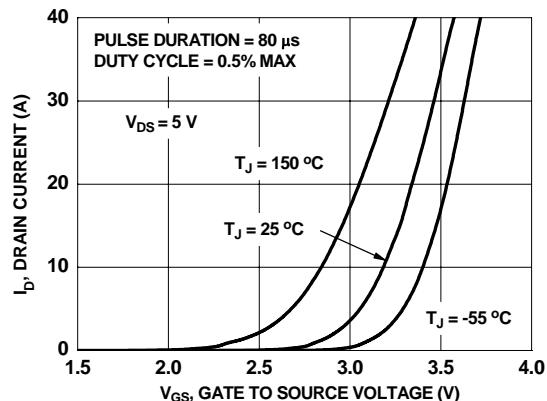


Figure 5. Transfer Characteristics

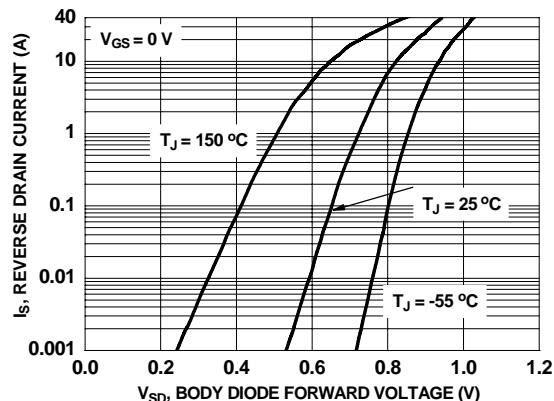


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

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Typical Characteristics (Q1 N-Channel) $T_J = 25^\circ\text{C}$ unless otherwise noted

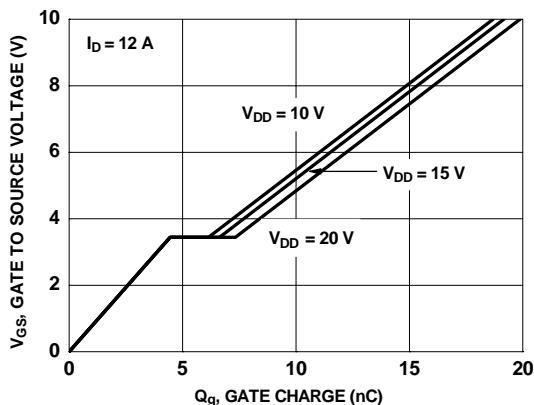


Figure 7. Gate Charge Characteristics

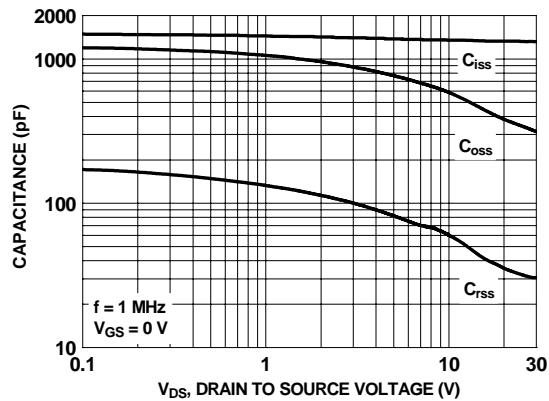


Figure 8. Capacitance vs Drain to Source Voltage

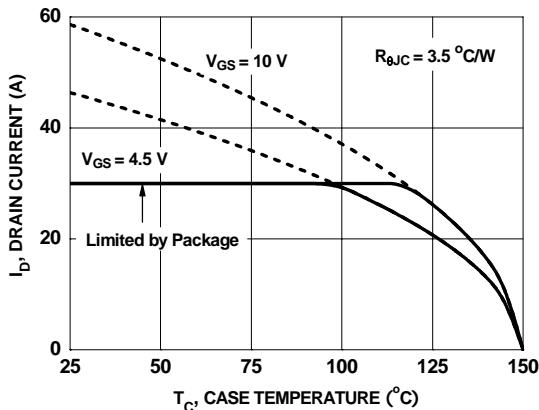


Figure 9. Maximum Continuous Drain Current vs Case Temperature

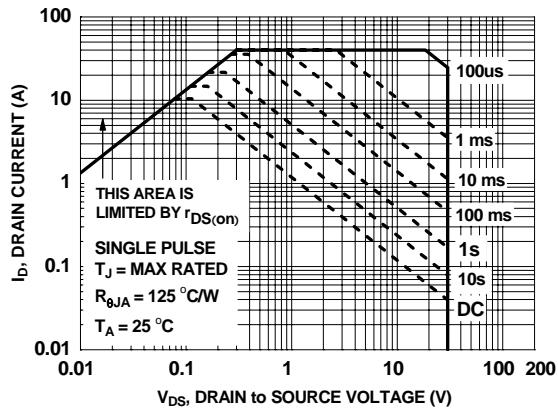


Figure 10. Forward Bias Safe Operating Area

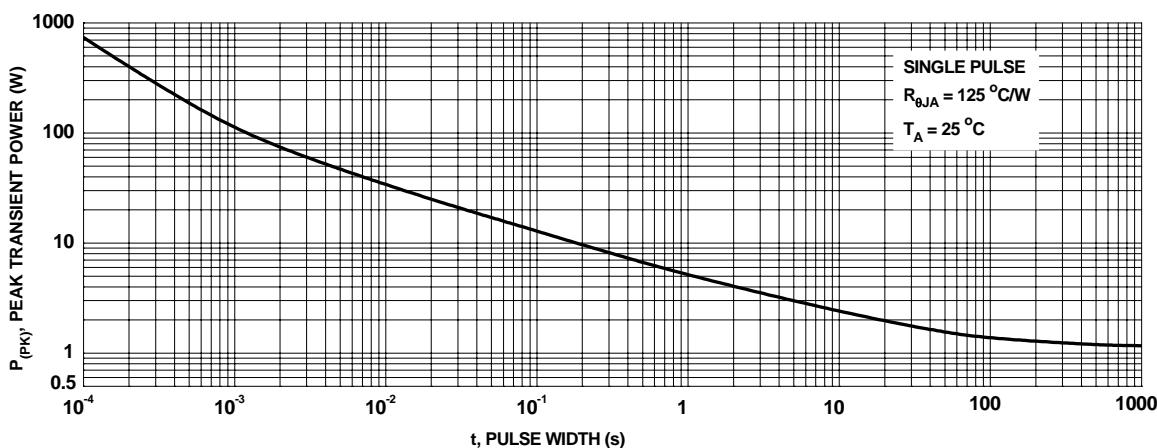


Figure 11. Single Pulse Maximum Power Dissipation

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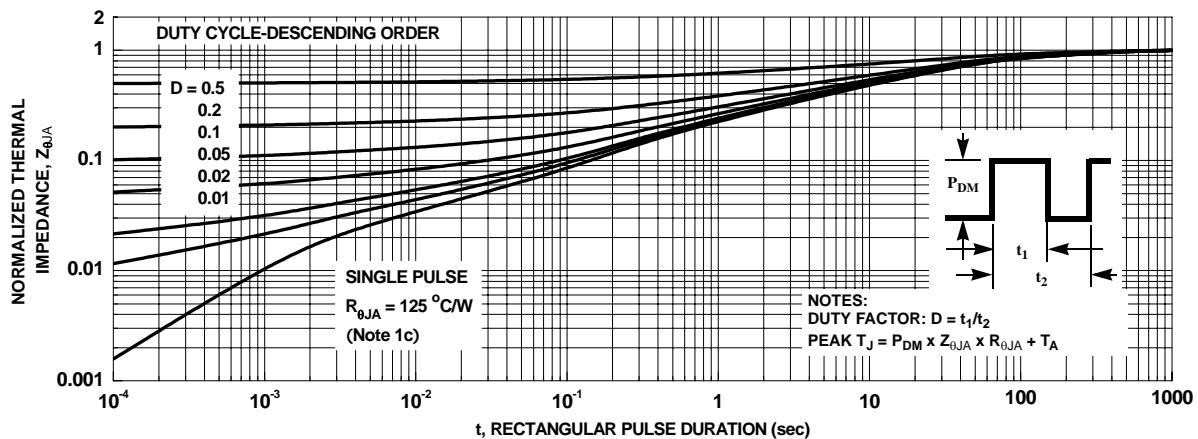
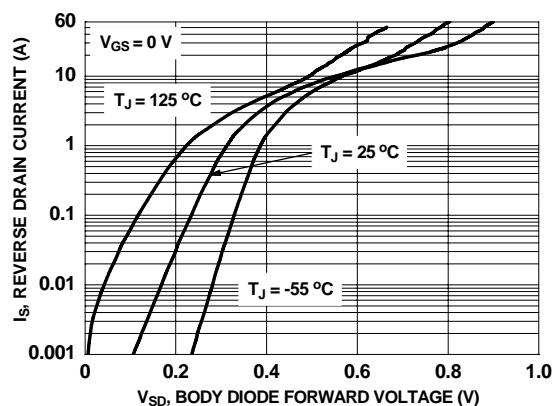
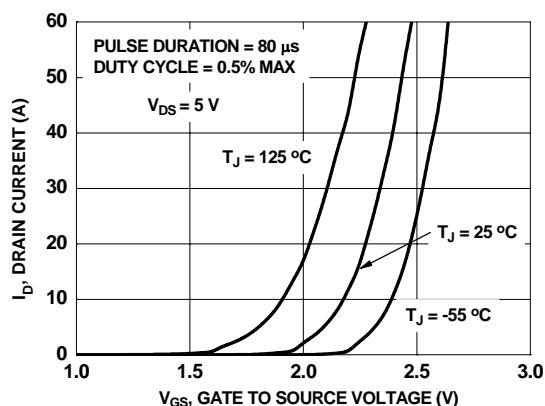
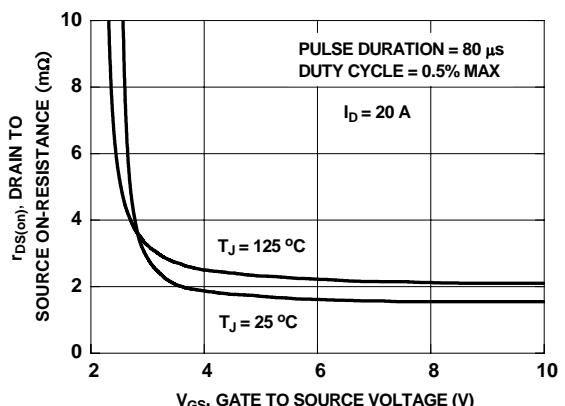
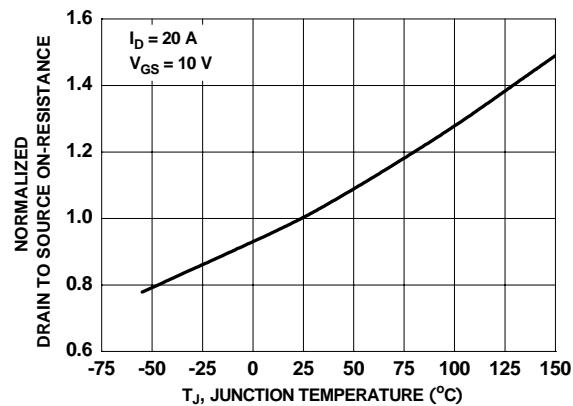
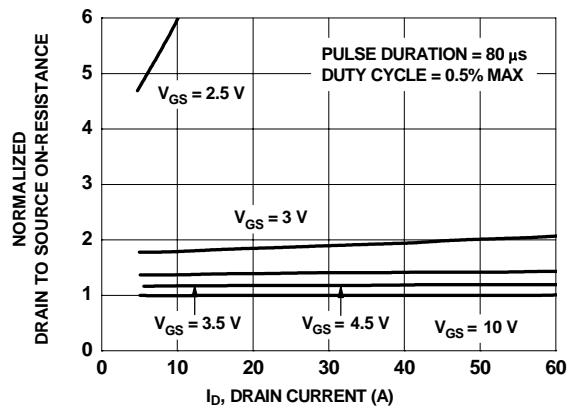
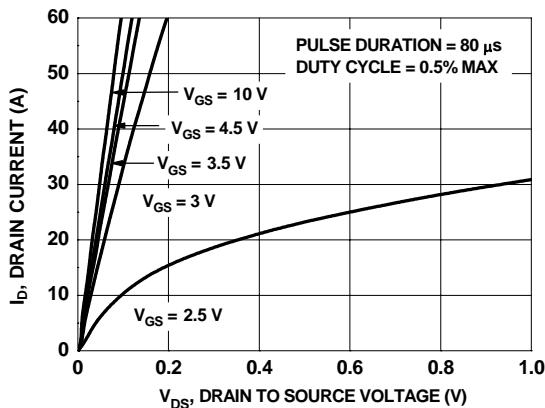


Figure 12. Junction-to-Ambient Transient Thermal Response Curve

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Typical Characteristics (Q2 SyncFET)



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Typical Characteristics (Q2 SyncFET)

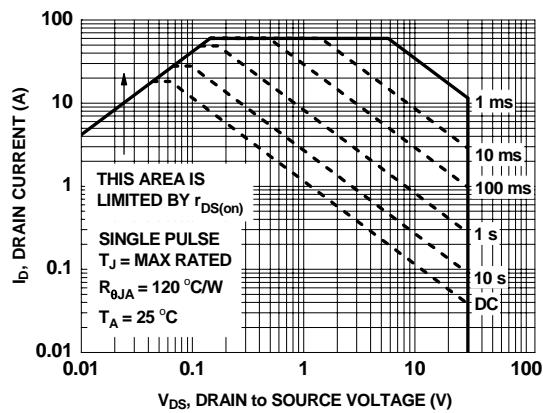
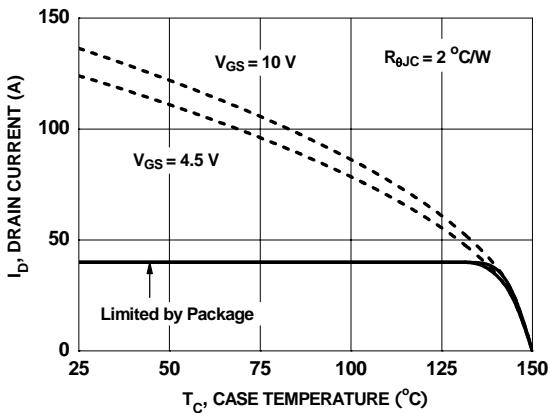
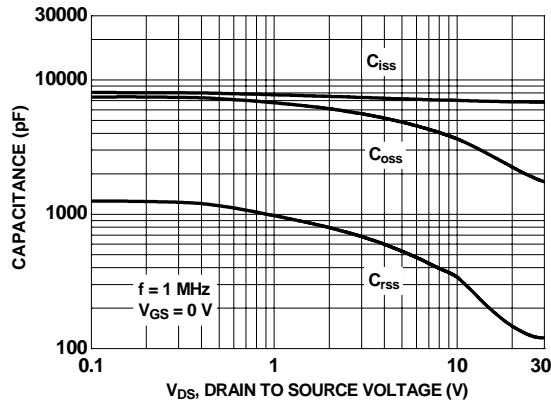
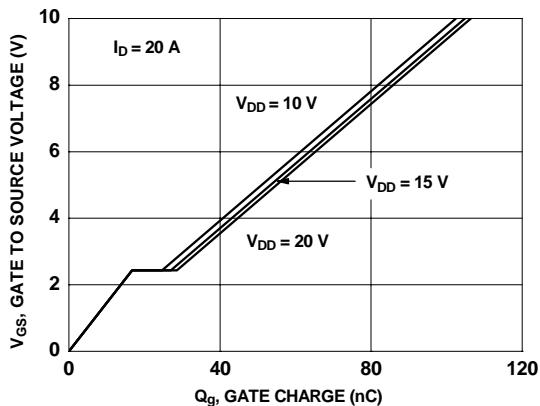
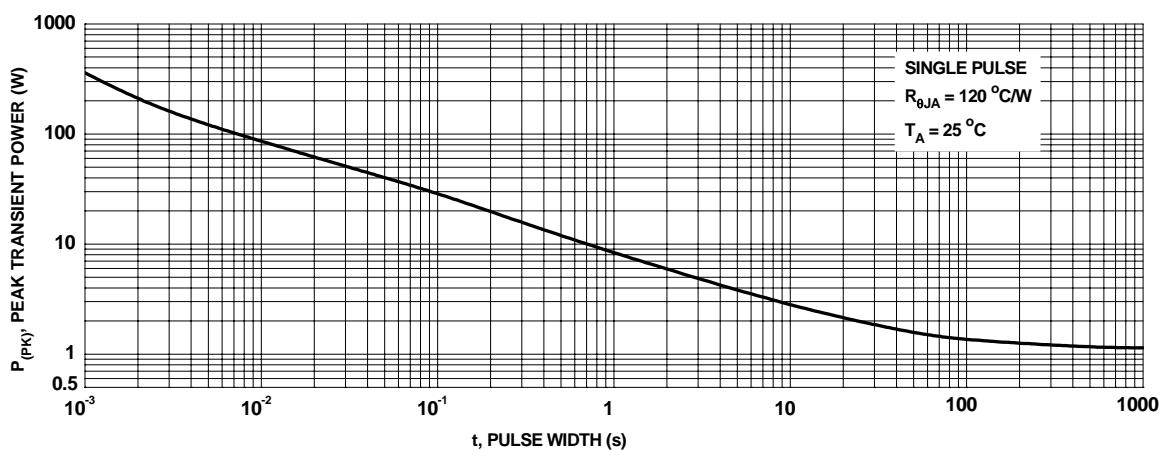


Figure 21. Maximum Continuous Drain Current vs Case Temperature

Figure 22. Forward Bias Safe Operating Area



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Typical Characteristics (Q2 SyncFET)

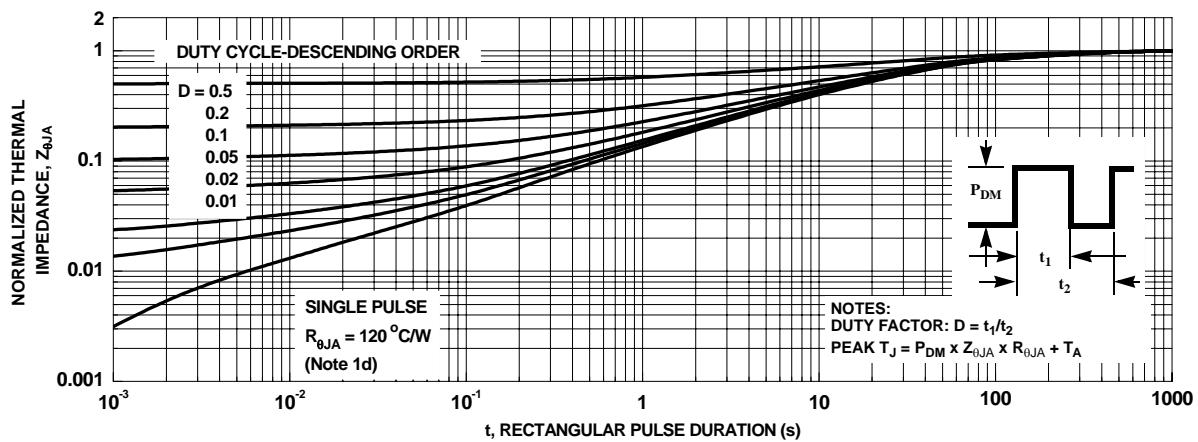


Figure 24. Junction-to-Ambient Transient Thermal Response Curve

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Typical Characteristics (continued)

SyncFET Schottky body diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 25 shows the reverse recovery characteristic of the FDMS7700S.

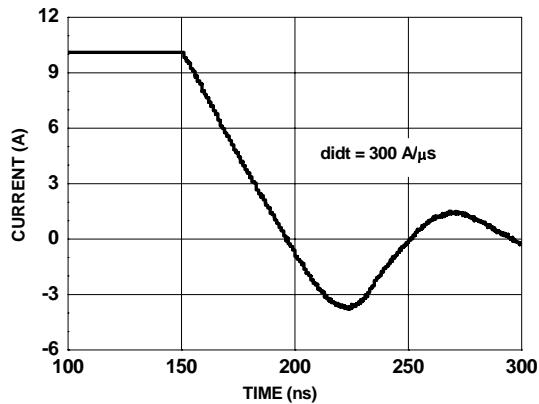


Figure 25. FDMS7700S SyncFET body diode reverse recovery characteristic

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

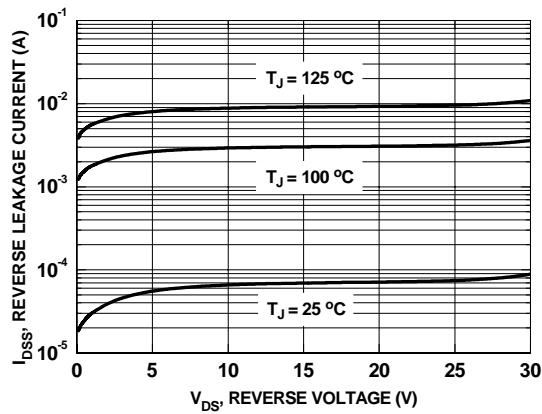
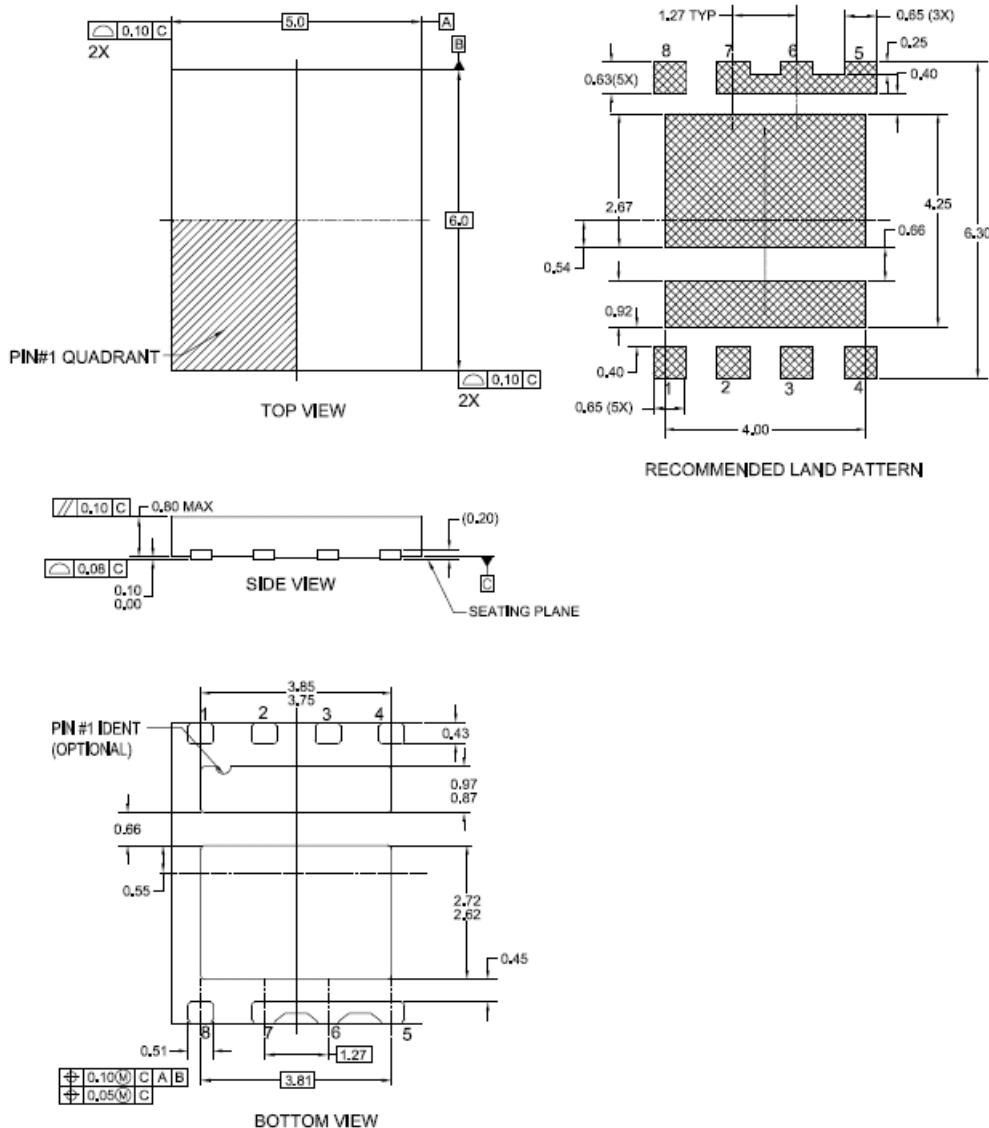


Figure 26. SyncFET body diode reverse leakage versus drain-source voltage

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Dimensional Outline and Pad Layout



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Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

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